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AI-304-2017

FACULTY OF SCIENCE

M.Sc. (First Semester) EXAMINATION

MARCH/APRIL, 2017

(CBCS Pattern)

CHEMISTRY

(Paper IV CH-414)

(Physical Methods in Chemistry-I)

(Thursday, 27-4-2017)

Time: 10.00 a.m. to 1.00 p.m.

Time— Three Hours

Maximum Marks—75

N.B. := (i) Attempt All questions.

- (ii) Use of calculator and logarithm table is allowed.
- 1. Attempt any three of the following:

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- (a) Explain conjugacy relation and classes.
- (b) Explain flow chart for chemical concept.
- (c) Explain high level and low level languages.
- (d) Determine the Miller indices for the plane having intercepts to the crystal axes as:
 - (i) $(a, -2b, \infty c)$ and

(ii)
$$\left(-a, \frac{1}{2}b, \infty c\right)$$
.

(e) Give an account of Ramchandran diagram.

P.T.O.

2. Solve any three of the following:

- 15
- (a) Define group, subgroup and order of group. Give the relation between groups and its subgroups.
- (b) Explain secondary storage devices.
- (c) In X-ray analysis of NaCl crystal, for (110) plane the first order reflection was found at 8.4°, for X-rays of wavelength 1.54 Å. Calculate the interplanar spacing in picometer.
- (d) Give an account of Wierl equation.
- (e) Explain the measurement technique used for neutron diffraction. Give the advantages of neutron diffraction.
- 3. Attempt the following:
 - (a) Explain the principles of programming. Give the algorithm steps for the evaluation of pH.

Or

Give the programming steps for:

- (i) radioactive decay
- (ii) $\left(p + \frac{a}{V^2}\right)(V b) = RT$.
- (b) Define symmetry operations and symmetry elements. Explain proper axis of rotation.

Or

Describe the matrix representation for:

- (i) C_2h
- (ii) C_{3v} point groups.

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4. At	tempt the following:
(a	Explain the different types of commands used in DOS operating system.
	Derive $n\lambda = 2d \sin \theta$. Explain the Laue method for determinating of crystal structure.
(b)	Give an account of structure of simple lattices and X-ray intensities.
	Explain the factors affecting X-ray intensities.
	Give an account of scattering intensity. What would be the wavelength of an electron beam accelerated by an applied potential difference of 30.000 Volts to produce diffraction pattern?
	$(h = 6.62 \times 10^{-34} \text{ Js}, m_e = 9.1 \times 10^{-31} \text{ kg}, e = 1.6 \times 10^{-19} \text{ coulomb}).$
5. (A	Select the <i>correct</i> alternative for the following:
	(i) MICR stands for :
	(a) Magnetic ink character reader
5	(b) Magnetic ink code reader
	(c) Magnetic ink cases reader
	(d) None of the above
	(ii) CH_4 belongs to :
	(a) C_{2V} (b) C_{3V}
	(c) C_{4h} (d) T_d

(iii)

is given by:

(*a*)

(c)

P.T.O.

de-Broglie's equation (b)

Planck's equation

The total intensity for a molecule consisting of a number of atoms

(d)

Debye equation

Wierl equation

- (iv) Monochromatic neutron beam can be produced by:
 - (a) reflection from crystal
 - (b) total reflaction from highly polised surfaces
 - (c) Both (a) and (b)
 - (d) None of the above
- (v) X-ray are electromagnetic radiation with wavelength of the order:
 - (a) 10 m₃

(b) 10^{10} m

- (c) 10⁻¹⁰ m
- $(d) \qquad \frac{1}{10} \quad \mathbf{m}$
- (B) Write short notes on any two of the following:

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- (i) Data processing
- (ii) Reducible and irreducible representation
- (iii) Scattering of neutron by solids and liquids.